Date: Wed, 8 Jul 2009 23:27:21 -0400

Reply-To: Michelle Maas Deane <mmaasdeane@ANSI.ORG> **From:** Michelle Maas Deane <mmaasdeane@ANSI.ORG>

Subject: HITSP 09 N 416 - Document Added for Public Comment Period on Quality

Content-Type: multipart/mixed;

[multipart/alternative]

Document Number: HITSP 09 N 416

Date: July 8, 2009

TO: Healthcare Information Technology Standards Panel (HITSP) and

Public Stakeholders - - FOR REVIEW AND ACTION

FROM: Michelle Maas Deane

HITSP Secretariat

American National Standards Institute

RE: Document Added for Public Comment Period on Quality

Attached please find a Reference Document which provides a full example of the use of the Quality Interoperability Specification to express one of the Stroke quality measures (STK-3) provided to HITSP by CMS.

HITSP members and public stakeholders are encouraged to review this document along with the Quality Interoperability Specification and supporting components (C105, C106, and C34) and provide comments through the HITSP comment tracking system. The documents and the HITSP comment tracking system are also accessible through www.hitsp.org http://www.hitsp.org/ The public comment period will be open until Close of Business, Thursday, July 30, 2009.

All Panel and public comments received on this document will be reviewed and dispositioned by the HITSP Technical Committees (TCs) in preparation of reference material for the complete set of measures (Stroke, VTE, and ED) provided to HITSP by CMS which will be released in September.

HITSP members and public stakeholders are encouraged to work with the Technical Committees as they continue the process of construct development. If your organization is a HITSP member and you are not currently signed up as a Technical Committee member, but would like to participate in this process, please contact aclemons@himss.org

Michelle Maas Deane HITSP Secretariat American National Standards Institute 25 West 43rd Street - Fourth Floor New York, NY 10036

T: 1.212.642.4884 F: 1.212.398.0023 E: mmaasdeane@ansi.org <blocked::mailto:mmaasdeane@ansi.org>